

Abstract Submitted  
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**Electroluminescence Spectral Shape in Carbon Nanotube Field Effect Transistors under High Bias Conditions** MEGUMI KINOSHITA, Stony Brook University, VASIL PEREBEINOS, MATHIAS STEINER, PHAEDON AVOURIS, IBM THOMAS WATSON RESEARCH CENTER TEAM — In carbon nanotube field effect transistors, electroluminescence excited by intra-nanotube impact excitation at high source-drain bias reveals strongly broadened electronic transitions (FWHM  $\sim 150$  to  $\sim 300$  meV for the lowest energy peak observed) in the  $E_{11}$  to  $E_{22}$  energy range. Through the bias and polarization dependence of the spectra, we investigate the production mechanism of these states and consider possible causes for their bias-dependent broad lineshapes, including exciton-exciton annihilation, and high electron and phonon temperatures.

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